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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Summary	Application No. 10/664,918	Applicant(s) OGURA ET AL.
	Examiner USMAN KHAN	Art Unit 2622

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
 - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
 - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 30 January 2009 and 13 February 2009.
- 2a) This action is FINAL. 2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1-3.5 and 8-16 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) Claim(s) _____ is/are allowed.
- 6) Claim(s) 1-3.5 and 8-16 is/are rejected.
- 7) Claim(s) _____ is/are objected to.
- 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on 22 September 2003 and 08 March 2007 is/are: a) accepted or b) objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All b) Some * c) None of:
1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) Notice of References Cited (PTO-892)
- 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) Information Disclosure Statement(s) (PTO/SB/08)
Paper No./Mail Date _____
- 4) Interview Summary (PTO-413)
Paper No./Mail Date _____
- 5) Notice of Informal Patent Application
- 6) Other: _____

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 02/13/2009 has been entered.

Response to Arguments

Applicant's arguments filed on 01/30/2009 with respect to claims 1, 9, and 10 have been considered but are moot in view of the new ground(s) of rejection.

DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1 - 2, 5, and 8 - 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Applicants Admitted Prior Art (hereafter referred as AAPA; note the examiner is using the PgPub 2004/0057719 to refer to the paragraph numbers and such), in view of Inui (US PgPub No. 2001/0025969), and in further view of YAMAMURA et al. (JP 08256296 A).

Regarding **claim 1**, AAPA teaches a solid state image pick-up device formed on a chip, comprising:

a pixel region (figures 7 and 8; Note: figures 7A,7B and 8 are prior art and the applicant has submitted an amendment to the drawing to label these figures as prior art); horizontal scanning circuit arranged along side of the chip (figure 8, item 205); a vertical scanning circuit arranged along a side of the chip not parallel to a side of the chip along which a horizontal scanning circuit is arranged, wherein the vertical scanning circuit has a lower driving frequency than that of the horizontal scanning circuits (figure 8, item 202 and paragraphs 0014 - 0016); and an amplifier for amplifying the signal charge read from the pixel region by the horizontal scanning circuits (figure 8 item 207), outputting video signals (note this outputting of the video signal is not associated with any component as claimed so the examiner can consider any item such as item 207, 201, 204, 206 or any component as outputting video signal to be used later, in this case the examiner chooses item any one or a combination of these items).

However, AAPA fails to disclose horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

Inui, on the other hand teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

More specifically, Inui teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region (figures 1and 12; horizontal scanning circuits).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of Inui with the teachings of AAPA to have a faster method of readout and to make the image readout process faster.

However, AAPA in view of Inui fail to disclose a pad for outputting the video signals to an outside of the chip, the pad being arranged along a side of the chip along which none of the horizontal scanning circuits and the vertical scanning circuit is arranged.

YAMAMURA et al., on the other hand teaches a pad for outputting the video signals to an outside of the chip, the pad being arranged along a side of the chip along which none of the horizontal scanning circuits and the vertical scanning circuit is arranged.

More specifically, YAMAMURA et al. teaches a pad for outputting the video signals to an outside of the chip, the pad being arranged along a side of the chip along which none of the horizontal scanning circuits and the vertical scanning circuit is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of YAMAMURA et al. with the teachings of AAPA in view of Inui because in page 1 lines 5 – 8 and page 5 lines 4 – 17 also paragraphs 0009, 0012, 0013, and 0016 YAMAMURA et al. teaches that using the invention flaring problems can be reduced and corrected which in turn will produce an improved image.

Regarding **claim 2**, as mentioned above in the discussion of claim 1, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, AAPA teaches that wherein in the pixel region, pixels having an active element are two-dimensionally arranged (figure 7A and 8 with active elements 201, 204, and 206).

Regarding **claim 5**, as mentioned above in the discussion of claim 2, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, Inui teaches that the pixel region is formed into a rectangle, and the horizontal scanning circuits are arranged closer to a long side of the pixel region (figures 1and 12; horizontal scanning circuits).

Regarding **claim 8**, as mentioned above in the discussion of claim 1, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim.

Additionally, AAPA teaches a signal processing unit for processing a signal from the solid state image pick-up device (Paragraphs 0005 – 0018, processing of the pixels and outputting of the image is done by a processor even though it is not specifically discussed).

However, AAPA fails to disclose a lens for forming an optical image of a subject.

YAMAMURA et al., on the other hand teaches a lens for forming an optical image of a subject.

More specifically, YAMAMURA et al. teaches a camera including a lens for forming an optical image of a subject (Page 1 lines 10 – 21 also paragraphs 0004 and 0007 – 0009).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of YAMAMURA et al. with the teachings of AAPA in view of Inui because in page 1 lines 5 – 8 and page 5 lines 4 – 17 also paragraphs 0009, 0012, 0013, and 0016 YAMAMURA et al. teaches that using the invention flaring problems can be reduced and corrected which in turn will produce an improved image.

Regarding **claim 9**, AAPA teaches a solid state image pick-up device formed on a chip, comprising:

a pixel region (figures 7 and 8; Note: figures 7A,7B and 8 are prior art and the applicant has submitted an amendment to the drawing to label these figures as prior art); horizontal scanning circuit arranged along side of the chip (figure 8, item 205); a

vertical scanning circuit arranged along a side of the chip not parallel to a side of the chip along which a horizontal scanning circuit is arranged, wherein the vertical scanning circuit has a lower driving frequency than that of the horizontal scanning circuits (figure 8, item 202 and paragraphs 0014 - 0016); and an amplifier for amplifying the signal charge read from the pixel region by the horizontal scanning circuits (figure 8 item 207), outputting video signals (note this outputting of the video signal is not associated with any component as claimed so the examiner can consider any item such as item 207, 201, 204, 206 or any component as outputting video signal to be used later, in this case the examiner chooses item any one or a combination of these items).

However, AAPA fails to disclose horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

Inui, on the other hand teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

More specifically, Inui teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region (figures 1 and 12; horizontal scanning circuits).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of Inui with the teachings of AAPA to have a faster method of readout and to make the image readout process faster.

However, AAPA in view of Inui fail to disclose a pad for supplying a voltage to the amplifier, the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged.

YAMAMURA et al., on the other hand teaches a pad for supplying a voltage to the amplifier, the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged.

More specifically, YAMAMURA et al. teaches a pad for supplying a voltage to the amplifier (pads supply all power to the pixel region), the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of YAMAMURA et al. with the teachings of AAPA in view of Inui because in page 1 lines 5 – 8 and page 5 lines 4 – 17 also paragraphs 0009, 0012, 0013, and 0016 YAMAMURA et al. teaches that using the invention flaring problems can be reduced and corrected which in turn will produce an improved image.

Regarding **claim 10**, AAPA teaches a solid state image pick-up device formed on a chip, comprising:

a pixel region (figures 7 and 8; Note: figures 7A,7B and 8 are prior art and the applicant has submitted an amendment to the drawing to label these figures as prior art); horizontal scanning circuit arranged along side of the chip (figure 8, item 205); a vertical scanning circuit arranged along a side of the chip not parallel to a side of the chip along which a horizontal scanning circuit is arranged, wherein the vertical scanning circuit has a lower driving frequency than that of the horizontal scanning circuits (figure 8, item 202 and paragraphs 0014 - 0016); and an amplifier for amplifying the signal charge read from the pixel region by the horizontal scanning circuits (figure 8 item 207), outputting video signals (note this outputting of the video signal is not associated with any component as claimed so the examiner can consider any item such as item 207, 201, 204, 206 or any component as outputting video signal to be used later, in this case the examiner chooses item any one or a combination of these items).

However, AAPA fails to disclose horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

Inui, on the other hand teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region.

More specifically, Inui teaches horizontal scanning circuits arranged along sides of the chip sandwiching the pixel region for reading a signal charge from the pixel region (figures 1and 12; horizontal scanning circuits).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of Inui with the teachings of AAPA to have a faster method of readout and to make the image readout process faster.

However, AAPA in view of Inui fails to disclose a pad for supplying a predetermined voltage or a ground voltage to an active element included in a pixel in the pixel region, the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged.

YAMAMURA et al., on the other hand teaches a pad for supplying a predetermined voltage or a ground voltage to an active element included in a pixel in the pixel region, the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged.

More specifically, YAMAMURA et al. teaches a pad for supplying a predetermined voltage or a ground voltage to an active element included in a pixel in the pixel region (pads supply all power to the pixel region), the pad being arranged only along a side portion of the chip not parallel to the side portion along which the first shift register is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of YAMAMURA et al. with the teachings of AAPA in view of Inui because in page 1 lines 5 – 8 and page 5 lines 4 – 17

also paragraphs 0009, 0012, 0013, and 0016 YAMAMURA et al. teaches that using the invention flaring problems can be reduced and corrected which in turn will produce an improved image.

Regarding **claim 11**, as mentioned above in the discussion of claim 1, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, Inui teaches that side portions along which the horizontal scanning circuits are arranged and a side portion along which the vertical scanning circuit is arranged are adjacent to each other (figures 1and 12; horizontal scanning circuits and vertical scanning circuit).

Regarding **claim 12**, as mentioned above in the discussion of claim 9, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, Inui teaches that side portions along which the horizontal scanning circuits are arranged and a side portion along which the vertical scanning circuit is arranged are adjacent to each other (figures 1and 12; horizontal scanning circuits and vertical scanning circuit).

Regarding **claim 13**, as mentioned above in the discussion of claim 10, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, Inui teaches that side portions along which the horizontal scanning circuits are arranged and a side portion along which the vertical scanning

circuit is arranged are adjacent to each other (figures 1 and 12; horizontal scanning circuits and vertical scanning circuit).

Regarding **claim 14**, as mentioned above in the discussion of claim 1, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, YAMAMURA et al. teaches that the pad is arranged only along a side portion of the chip at an angle of 90 degrees to a side portion along which a horizontal scanning circuit, of the horizontal scanning circuits, is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Regarding **claim 15**, as mentioned above in the discussion of claim 9, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, YAMAMURA et al. teaches that the pad is arranged only along a side portion of the chip at an angle of 90 degrees to a side portion along which a horizontal scanning circuit, of the horizontal scanning circuits, is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Regarding **claim 16**, as mentioned above in the discussion of claim 10, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. Additionally, YAMAMURA et al. teaches that the pad is arranged only along a side portion of the chip at an angle of 90 degrees to a side portion along which a horizontal scanning circuit, of the horizontal scanning circuits, is arranged (figures 1 – 2; pads arranged along vertical side of the chip away from the horizontal side where the horizontal registers are located and away from the vertical register; i.e. as shown by the location of the registers of AAPA and Inui).

Claim 3 is rejected under 35 U.S.C. 103(a) as being unpatentable over Applicants Admitted Prior Art (hereafter referred as AAPA; note the examiner is using the PgPub 2004/0057719 to refer to the paragraph numbers and such), in view of Inui (US PgPub No. 2001/0025969), and in further view of YAMAMURA et al. (JP 08256296 A) in further view of Itano et al. (US PgPub 2002/0051071).

Regarding **claim 3**, as mentioned above in the discussion of claim 2, AAPA in view of Inui and further in view of YAMAMURA et al. teach all of the limitations of the parent claim. However, AAPA in view of Inui and further in view of YAMAMURA et al. fail to disclose that the active element comprises at least one selected from the group consisting of a transfer MOS transistor, a reset MOS transistor, a source follower input MOS transistor, and a selection MOS transistor. Itano et al., on the other hand teaches that the active element comprises at least one selected from the group consisting of a

transfer MOS transistor, a reset MOS transistor, a source follower input MOS transistor, and a selection MOS transistor.

More specifically, Itano et al. teaches the active element comprises at least one selected from the group consisting of a transfer MOS transistor (figure 1 item 105, and paragraph 0006), a reset MOS transistor (figure 1 items 110a and 110b, and paragraph 0006), a source follower input MOS transistor (figure 1 item 107, and paragraphs 0006, 0048, 0051), and a selection MOS transistor (paragraph 0051).

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the teachings of Itano et al. with the teachings of AAPA in view of Inui and further in view of YAMAMURA et al. for reduction of size and in turn cost as taught in paragraph 0021 of Itano et al.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to USMAN KHAN whose telephone number is (571)270-1131. The examiner can normally be reached on Mon-Fri 6:45-3:15. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jason Chan can be reached on (571) 272-3022. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Usman Khan/
Usman Khan
04/07/2009
Patent Examiner

/James M Hannett/
Primary Examiner, Art Unit 2622